

Applicatio	n/Control No.	Applicant(s)/Pat Reexamination	ent under
10/829,58	3	CHEN ET AL.	
Examiner		Art Unit	
Leonardo	Andújar	2826	

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Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED						
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
257/690-799 (text serach only-see search history print out)	8/8/2005	LA